

# 2.5V Drive Pch+SBD MOSFET

# **ES6U42**

#### Structure

Silicon P-channel MOSFET / Schottky barrier diode

#### Features

- 1) Pch MOSFET and schottky barrier diode are put in WEMT6 package.
- 2) High-speed switching, Low On-resistance.
- 3) Low voltage drive (2.5V drive).
- 4) Built-in Low VF schottky barrier diode.

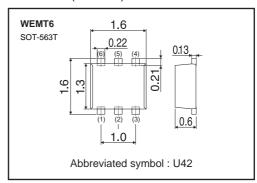
# Applications

Switching

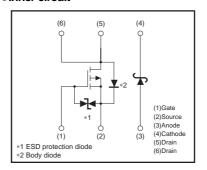
# Package specifications

	Package	Taping
Type	Code	T2R
	Basic ordering unit (pieces)	8000
ES6U42		0

# ●Dimensions (Unit:mm)



### •Inner circuit



# ● Absolute maximum ratings (Ta=25°C)

<MOSFET>

Parameter		Symbol	Limits	Unit
Drain-source voltage		VDSS	-20	V
Gate-source voltage		Vgss	±12	V
Dunin august	Continuous	ID	±1.0	A
Drain current	Pulsed	I <sub>DP</sub> *1	±4.0	A
Source current	Continuous	Is	-0.4	A
(Body diode)	Pulsed	I <sub>SP</sub> *1	-4.0	A
Channel temperature		Tch	150	°C
Power dissipation		P <sub>D</sub> *2	0.7	W / ELEMENT

<sup>\*1</sup> Pw≤10µs, Duty cycle≤1% \*2 Mounted on a ceramic board

VDI2				
Parameter	Symbol	Limits	Unit	
Repetitive peak reverse voltage	V <sub>RM</sub>	25	V	
Reverse voltage	VR	20	V	
Forward current	l <sub>F</sub>	0.5	A	
Forward current surge peak	I <sub>FSM</sub> *1	2.0	Α	
Junction temperature	Tj	150	°C	
Power dissipation	Pn *2	0.5	W / ELEMENT	

#### <MOSFET and Di>

Parameter	Symbol	Limits	Unit	
Power dissipation	P <sub>D</sub> *	0.8	W / TOTAL	
Range of storage temperature	Tstg	-55 to +150	°C	

<sup>\*</sup> Mounted on a ceramic board

<sup>\*1 60</sup>Hz • 1 cycle \*2 Mounted on a ceramic board

# ●Electrical characteristics (Ta=25°C)

<MOSFET>

Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
Gate-source leakage	Igss	_	_	±10	μА	Vgs= ±12V, Vps=0V
Drain-source breakdown voltage	V(BR) DSS	-20	-	_	V	I <sub>D</sub> = -1mA, V <sub>GS</sub> =0V
Zero gate voltage drain current	IDSS	-	-	-1	μΑ	V <sub>DS</sub> = -20V, V <sub>GS</sub> =0V
Gate threshold voltage	V <sub>GS (th)</sub>	-0.7	_	-2.0	V	V <sub>DS</sub> = -10V, I <sub>D</sub> = -1mA
Static drain course on state		_	280	390	mΩ	I <sub>D</sub> = -1A, V <sub>G</sub> S= -4.5V
Static drain-source on-state resistance	R <sub>DS</sub> (on)*	_	310	430	mΩ	I <sub>D</sub> = -1A, V <sub>G</sub> S= -4V
resistance		_	570	800	mΩ	I <sub>D</sub> = -0.5A, V <sub>G</sub> S= -2.5V
Forward transfer admittance	Y <sub>fs</sub> *	0.7	-	_	S	V <sub>DS</sub> = -10V, I <sub>D</sub> = -0.5A
Input capacitance	Ciss	_	150	_	pF	V <sub>DS</sub> = -10V
Output capacitance	Coss	_	20	_	pF	V <sub>GS</sub> = 0V
Reverse transfer capacitance	Crss	-	20	-	pF	f= 1MHz
Turn-on delay time	t <sub>d (on)</sub> *	_	9	_	ns	V <sub>DD</sub> ≒ –15V
Rise time	tr *	_	8	_	ns	Vgs= -4.5V
Turn-off delay time	t <sub>d (off)</sub> *	-	25	_	ns	lb= −0.5A RL≒30Ω
Fall time	t <sub>f</sub> *	_	10	_	ns	R <sub>G</sub> = 10Ω
Total gate charge	Qg *	_	2.1	-	nC	V <sub>DD</sub> ≒-15V, V <sub>GS</sub> =-4.5V
Gate-source charge	Q <sub>gs</sub> *	_	0.5	_	nC	I <sub>D</sub> =−1A, R <sub>L</sub> ≒15Ω
Gate-drain charge	Q <sub>gd</sub> *	_	0.5	_	nC	R <sub>G</sub> = 10Ω

<sup>\*</sup>Pulsed

# <Body diode characteristics (Source-drain)>

Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
Forward voltage	Vsp *	-	_	-1.2	V	I <sub>S</sub> = -1.0A, V <sub>G</sub> S=0V

<sup>\*</sup>Pulsed

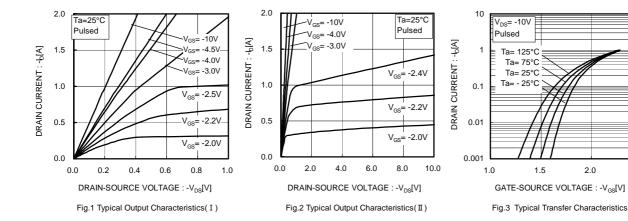
# <Di>

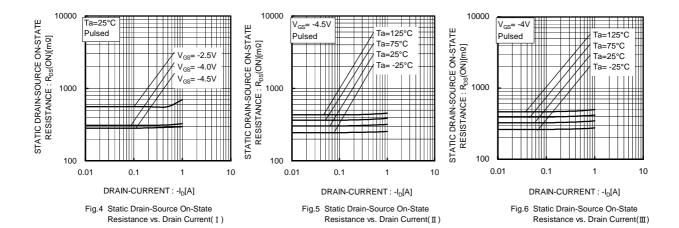
Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
Forward voltage	V <sub>F</sub>	_	_	0.36	V	I <sub>F</sub> = 0.1A
		_	_	0.52	V	IF= 0.5A
Reverse current	IR	_	_	100	μΑ	V <sub>R</sub> = 20V

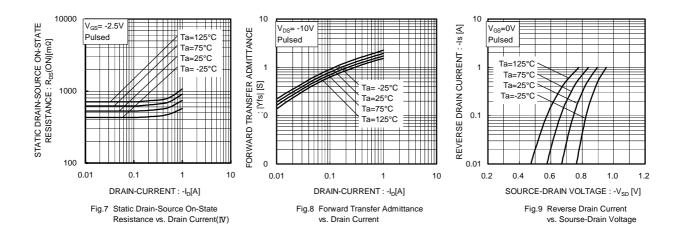
2.5

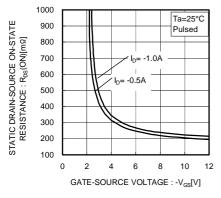
#### Electrical characteristics curves

#### <MOSFET>









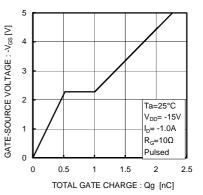


Fig.10 Static Drain-Source On-State Resistance vs. Gate Source Voltage

Fig.11 Switching Characteristics

Fig.12 Dynamic Input Characteristics

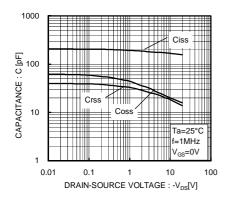


Fig.13 Typical Capacitance vs. Drain-Source Voltage

# <Di>

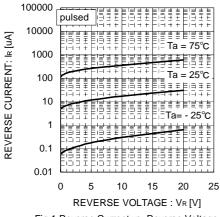
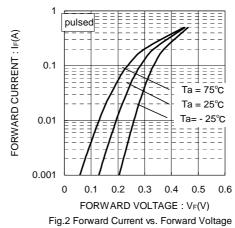


Fig.1 Reverse Current vs. Reverse Voltage



0

4/5

#### ●Measurement circuit

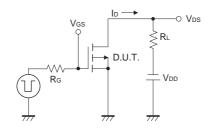


Fig.1-1 Switching Time Measurement Circuit

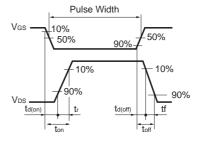


Fig.1-2 Switching Waveforms

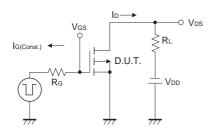
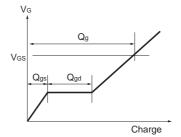


Fig.2-1 Gate Charge Measurement Circuit



Flg.2-2 Gate Charge Waveform

### ●Notice

- 1. SBD has a large reverse leak current compared to other type of diode. Therefore; it would raise a junction temperature, and increase a reverse power loss. Further rise of inside temperature would cause a thermal runaway.
  - This built-in SBD has low VF characteristics and therefore, higher leak current. Please consider enough the surrounding temperature, generating heat of MOSFET and the reverse current.
- 2. This product might cause chip aging and breakdown under the large electrified environment. Please consider to design ESD protection circuit.

### **Notes**

No copying or reproduction of this document, in part or in whole, is permitted without the consent of ROHM CO.,LTD.

The content specified herein is subject to change for improvement without notice.

The content specified herein is for the purpose of introducing ROHM's products (hereinafter "Products"). If you wish to use any such Product, please be sure to refer to the specifications, which can be obtained from ROHM upon request.

Examples of application circuits, circuit constants and any other information contained herein illustrate the standard usage and operations of the Products. The peripheral conditions must be taken into account when designing circuits for mass production.

Great care was taken in ensuring the accuracy of the information specified in this document. However, should you incur any damage arising from any inaccuracy or misprint of such information, ROHM shall bear no responsibility for such damage.

The technical information specified herein is intended only to show the typical functions of and examples of application circuits for the Products. ROHM does not grant you, explicitly or implicitly, any license to use or exercise intellectual property or other rights held by ROHM and other parties. ROHM shall bear no responsibility whatsoever for any dispute arising from the use of such technical information.

The Products specified in this document are intended to be used with general-use electronic equipment or devices (such as audio visual equipment, office-automation equipment, communication devices, electronic appliances and amusement devices).

The Products are not designed to be radiation tolerant.

While ROHM always makes efforts to enhance the quality and reliability of its Products, a Product may fail or malfunction for a variety of reasons.

Please be sure to implement in your equipment using the Products safety measures to guard against the possibility of physical injury, fire or any other damage caused in the event of the failure of any Product, such as derating, redundancy, fire control and fail-safe designs. ROHM shall bear no responsibility whatsoever for your use of any Product outside of the prescribed scope or not in accordance with the instruction manual.

The Products are not designed or manufactured to be used with any equipment, device or system which requires an extremely high level of reliability the failure or malfunction of which may result in a direct threat to human life or create a risk of human injury (such as a medical instrument, transportation equipment, aerospace machinery, nuclear-reactor controller, fuel-controller or other safety device). ROHM shall bear no responsibility in any way for use of any of the Products for the above special purposes. If a Product is intended to be used for any such special purpose, please contact a ROHM sales representative before purchasing.

If you intend to export or ship overseas any Product or technology specified herein that may be controlled under the Foreign Exchange and the Foreign Trade Law, you will be required to obtain a license or permit under the Law.

Thank you for your accessing to ROHM product informations.

More detail product informations and catalogs are available, please contact your nearest sales office.

**ROHM Customer Support System** 

THE AMERICAS / EUROPE / ASIA / JAPAN

www.rohm.com

Contact us : webmaster @ rohm.co.jp

Copyright © 2009 ROHM Co.,Ltd.

ROHM Co., Ltd. 21 Saiin Mizosaki-cho, Ukyo-ku, Kyoto 615-8585, Japan

TEL:+81-75-311-2121 FAX:+81-75-315-0172

